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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/867,159	05/29/2001	Emile Loria	01-346	5964

26941 7590 10/18/2005
MANDEL & ADRIANO
55 SOUTH LAKE AVENUE
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PASADENA, CA 91101

EXAMINER

HUYNH, PHUONG N

ART UNIT PAPER NUMBER

1644

DATE MAILED: 10/18/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

Examiner-Initiated Interview Summary

Application No.

09/867,159

Applicant(s)

LORIA ET AL.

Examiner

Phuong Huynh

Art Unit

1644

All Participants:

(1) Phuong Huynh.

(2) Sarah B Adriano.

Status of Application: Allowance

(3) _____

(4) _____

Date of Interview: 17 October 2005

Time: _____

Type of Interview:

☒ Telephonic

☐ Video Conference

☐ Personal (Copy given to: ☐ Applicant ☐ Applicant's representative)

Exhibit Shown or Demonstrated: ☐ Yes ☐ No

If Yes, provide a brief description:

Part I.

Rejection(s) discussed:

Claims discussed:

75-76

Prior art documents discussed:

Part II.

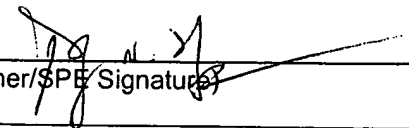
SUBSTANCE OF INTERVIEW DESCRIBING THE GENERAL NATURE OF WHAT WAS DISCUSSED:

Applicants agreed to the changes set forth in the Examiner's Amendment.

Part III.

☒ It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview directly resulted in the allowance of the application. The examiner will provide a written summary of the substance of the interview in the Notice of Allowability.

☐ It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview did not result in resolution of all issues. A brief summary by the examiner appears in Part II above.

(Examiner/SPB Signature) 

(Applicant/Applicant's Representative Signature – if appropriate)

EXAMINER'S AMENDMENT

1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.
2. Authorization for this examiner's amendment was given in a telephone interview with Sarah B Adriano on October 17, 2005
3. **In the claims:**
Claim 75, line 2, "the acarid allergen is" has been changed to -- the allergen is an epitope of --
Claim 76, line 2, "the acarid allergen is" has been changed to -- the allergen is an epitope of --
Claim 77, line 2, "the acarid allergen is" has been changed to -- the allergen is an epitope of --
4. Claims 74-83 are pending and are allowed.
5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Phuong Huynh "NEON" whose telephone number is (571) 272-0846. The examiner can normally be reached Monday through Friday from 9:00 am to 5:30 p.m. A message may be left on the examiner's voice mail service. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Christina Chan can be reached on (571) 272-0841. The IFW official Fax number is (571) 273-8300.
6. Any information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Phuong N. Huynh, Ph.D.

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Patent Examiner

Technology Center 1600

October 17, 2005

A handwritten signature in cursive script that reads "Christina Chan".

CHRISTINA CHAN
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 1600